

Notice of References Cited	Application/Control No. 10/811,861	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Albert H. Cutler	Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0179939	09-2003	Kim, Jae-Hyun	382/232
*	B	US-2004/0204144	10-2004	Lim, Chae-Whan	455/566
*	C	US-2004/0061902	04-2004	Tang et al.	358/003.01
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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